No. P-TCD-E005/1 DATE 2025-09

PRODUCTS DATA SHEET

Tantalum Solid Electrolytic Capacitors with Conductive Polymer

Type TCD

RoHS COMPLIANT LEAD FREE





OUTLINE (Type TCD)

Type TCD is a tantalum solid electrolytic capacitor which uses conductive polymer as cathode layer.

Their equivalent series resistance (ESR) is extremely lowered with the characteristics of the polymer having high electric conductivity.

This ensures higher permissible ripple current and excellent noise absorption performance on high-frequency circuits.

APPLICATION

DC/DC converters, power supply circuits, communication devices, home appliances, regulators and peripherals.

FEATURES

1. Low ESR and Low impedance

Using a conductive polymer as cathode layer makes low ESR and impedance possible.

Type TCD makes high permissible ripple current and is suitable for noise bypass application.

2. Stable ESR over temperature

ESR is extremely stable from low temperature through high temperature.

3. Compact and Large capacitance

The capacitor is smaller and has larger capacitance than ceramic capacitor and aluminum electrolytic capacitor.

4. Benign Failure Mode

Type TCD offers very safe characteristics which makes ignition and smoking harder by taking advantages of characteristics of conductive polymer if the capacitor be short-circuited.

5. Lead Free and RoHS Compliant.

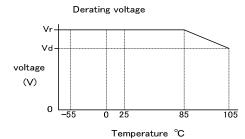
APPLICATION CLASSIFICATION BY USE

The application classification by use which divided the market and use into four is set up supposing our products being used for a broad use. Please confirm the application classification by use of each product that you intend to use.

Moreover, please be sure to inform to our Sales Department in advance in examination of the use of those other than the indicated use.

RATINGS

Item	Ratings
Category Temperature Range	-55 to +105 $^{\circ}$ C (to be used at derated voltage when temperature exceeds 85 $^{\circ}$ C)
Rated Voltage	2.5 - 4.0 - 6.3 - 10 - 16 - 20 - 25 - 35 -50 VDC
Derated Voltage	2.0 - 3.2 - 5.0 - 8.0 - 13 - 16 - 20 - 28 - 40 VDC(105°C)
Capacitance	3.3 to 470 μF
Capacitance Tolerance	±20 % (M)



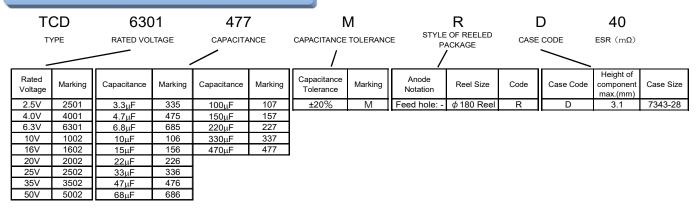
Derating voltage VT at any temperature T between 85°C and 105°C shall be calculated by the following formula.

$$VT = Vr - \frac{Vr - Vd}{20} (T - 85)$$

Vr:Rated voltage Vd:Derating voltage 105°C

Vr	Rated voltage (VDC)	2.5	4.0	6.3	10	16	20	25	35	50
Vd	Derating voltage (VDC)	2.0	3.2	5.0	8.0	13	16	20	28	40

ORDERING INFORMATION



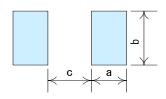
Note: For a capacitor with special requirements from customers, a 2-digit specific numbers will be added between the case code and the ESR for our product management.

DIMENSIONS



						(mm)
Case Code	Case Size	L	W ₁	Н	S	W_2
D	7343-28	7.30 ±0.30	4.30 ±0.30	2.80 ±0.30	1.30 ±0.30	2.40 ±0.20

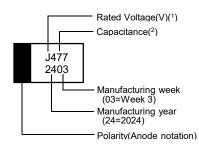
RECOMMENDED PAD DIMENSIONS



			(mm)
Case Code	а	b	С
D	2.4	2.7	4.6

In order to expect the self alignment effect, it is recommended that the land width is almost the same size as terminal of capacitor, and space between lands(c) nearly equal to the space between terminals for appropriate soldering.

MARKING



Note (1) Rated voltage is described as shown below.

	Rated Voltage Code								
Rated voltage	2.5	4.0	6.3	10	16	20	25	35	50
Code	F	G	J	Α	С	D	Е	V	Т

(2) Capacitance is expressed by 3 numbers.

47 7 • • • 47×10⁷ pF

STANDRARD RATING

Sep., 2025

						оор.,			
R.V.(VDC) Cap.(μF)	2.5	4.0	6.3	10	16	20	25	35	50
3.3									D(150)
4.7									D(150)
6.8								D(150)	D(150)
10							D(150)	D(200)	D(100)
15					D(90)	D(90)	D(90)	D(90)	
22					D(100)	D(100)	D(100)	D(100)	D(100)
33					D(100)	D(100)	D(100)	D(100)	D(100)
47					D(100)	D(100)	D(100)	D(100)	
68			D(100)	D(100)	D(100)	D(100)	D(100)		
100				D(100)	D(100)	D(100)	D(100)		
150		D(100)	D(100)	D(100)	D(100)				
220	D(60)	D(60)	D(60)	D(60)	D(60)				
330	D(50)	D(50)	D(50)	D(50)					
470	D(40)	D(40)	D(40)	D(60)					
680									

The parenthesized values show ESR.(maximum values in m Ω at 100kHz)

CATALOG NUMBERS AND RATING

Sep.,2025

						ОСР	.,2025		
Catalog number	Rated Voltage (VDC)	Capacitance (μF)	Tolerances (±%)	Case Code	Lct. (μA)	Max. Dissipation Factor 25°C	ESR (mΩ) 100kHz 25°C	Max. permissible Ripple Current (¹) (mArms) 100kHz 25°C	MSL
TCD 2501 227 MR D 0060	2.5	220	20	D	55	0.10	60	1936	3
TCD 2501 337 MR D 0050	↓	330	↓	D	83	0.10	50	2121	3
TCD 2501 477 MR D 0040	↓	470	↓	D	118	0.10	40	2372	3
TCD 4001 157 MR D 0100	4	150	20	D	60	0.10	100	1500	3
TCD 4001 227 MR D 0060	↓	220	↓	D	88	0.10	60	1936	3
TCD 4001 337 MR D 0050	↓	330	↓	D	132	0.10	50	2121	3
TCD 4001 477 MR D 0040	↓	470	↓	D	188	0.10	40	2372	3
TCD 6301 686 MR D 0100	6.3	68	20	D	43	0.10	100	1500	3
TCD 6301 157 MR D 0100	↓	150	↓	D	95	0.10	100	1500	3
TCD 6301 227 MR D 0060	1	220	↓	D	139	0.10	60	1936	3
TCD 6301 337 MR D 0050	1	330	↓	D	208	0.10	50	2121	3
TCD 6301 477 MR D 0040	1	470	, 	D	296	0.10	40	2372	3
TCD 1002 686 MR D 0100	10	68	20	D	68	0.10	100	1500	3
TCD 1002 107 MR D 0100	1	100	↓	D	100	0.10	100	1500	3
TCD 1002 157 MR D 0100	J	150	↓ ↓	D	150	0.10	100	1500	3
TCD 1002 227 MR D 0060	,	220	↓	D	220	0.10	60	1936	3
TCD 1002 337 MR D 0050	1	330	↓	D	330	0.10	50	2121	3
TCD 1002 477 MR D 0060	10	470	↓ 00	D	470	0.10	60	1936	3
TCD 1602 156 MR D 0090	16	15	20	D	24	0.10	90	1581	3
TCD 1602 226 MR D 0100	↓	22	↓	D	35	0.10	100	1500	3
TCD 1602 336 MR D 0100	↓	33	↓	D	53	0.10	100	1500	3
TCD 1602 476 MR D 0100	1	47	↓	D	75	0.10	100	1500	3
TCD 1602 686 MR D 0100	1	68	1	D	109	0.10	100	1500	3
TCD 1602 107 MR D 0100	1	100	1	D	160	0.10	100	1500	3
TCD 1602 157 MR D 0100	1	150	↓	D	240	0.10	100	1500	3
TCD 1602 227 MR D 0060	↓	220	↓	D	352	0.10	60	1936	3
TCD 2002 156 MR D 0090	20	15	20	D	30	0.10	90	1581	3
TCD 2002 226 MR D 0100	1	22	1	D	44	0.10	100	1500	3
TCD 2002 336 MR D 0100	1	33	Ţ	D	66	0.10	100	1500	3
TCD 2002 476 MR D 0100	1	47	1	D	94	0.10	100	1500	3
TCD 2002 686 MR D 0100	↓	68	↓	D	136	0.10	100	1500	3
TCD 2002 107 MR D 0100	↓	100	↓	D	200	0.10	100	1500	3
TCD 2502 106 MR D 0150	25	10	20	D	25	0.10	150	1225	3
TCD 2502 156 MR D 0090	1	15	1	D	37.5	0.10	90	1581	3
TCD 2502 226 MR D 0100	↓	22	↓	D	55	0.10	100	1500	3
TCD 2502 336 MR D 0100	↓	33	↓	D	82.5	0.10	100	1500	3
TCD 2502 476 MR D 0100	↓	47	↓	D	117.5	0.10	100	1500	3
TCD 2502 686 MR D 0100	1	68	1	D	170	0.10	100	1500	3
TCD 2502 107 MR D 0100	1	100	\downarrow	D	250	0.10	100	1500	3
TCD 3502 685 MR D 0150	35	6.8	20	D	23.8	0.10	150	1225	3
TCD 3502 106 MR D 0200	1	10	1	D	35	0.10	200	1061	3
TCD 3502 156 MR D 0090	1	15	↓	D	52.5	0.10	90	1581	3
TCD 3502 226 MR D 0100	1	22	↓	D	77	0.10	100	1500	3
TCD 3502 336 MR D 0100	↓	33	↓	D	115.5	0.10	100	1500	3
TCD 3502 476 MR D 0100	↓	47	↓	D	164.5	0.10	100	1500	3
TCD 5002 335 MR D 0150	50	3.3	20	D	16.5	0.10	150	1225	3
TCD 5002 475 MR D 0150	1	4.7	1	D	23.5	0.10	150	1225	3
TCD 5002 685 MR D 0150	1	6.8	↓	D	34	0.10	150	1225	3
TCD 5002 106 MR D 0100	1	10	↓	D	50	0.10	100	1500	3
TCD 5002 226 MR D 0100	↓	22	↓	D	110	0.10	100	1500	3
TCD 5002 336 MR D 0100	1	33	↓	D	165	0.10	100	1500	3
Notes: (1) Reference value	<u> </u>	L				I			

Notes : (1) Reference value.

PERFORMANCE

Applied Duratic Measu 2 Capacitance (µF) Shall be within specified tolerances. 3 Dissipation Factor Shall not exceed the values shown in CATALOG NUMBERS AND RATING. 4 Equivalent Series Resistance Shall not exceed the values shown in CATALOG NUMBERS AND RATING. 5 Surge Leakage current : Shall not exceed 3-times of the value in No.1. Capacitance change : Within ±20% of the value before test Dissipation Factor : Shall not exceed the value before test Dissipation Factor : Shall not exceed the value before test Dissipation Factor : Shall not exceed the value in No.3. Visual Examination : There shall be no evidence of mechanical damage. 6 Shear Test No separation of terminal from solder. 7 Substrate Bending Test Visual Examination : There shall be no evidence of mechanical damage. 8 Vibration Capacitance : Initial value to remain steady during measurement. Visual Examination : There shall be no evidence of mechanical damage. 8 Vibration Capacitance : Initial value to remain steady during measurement. Visual Examination : There shall be no evidence of mechanical damage. 9 Freque Vibration and Capacitance : Initial value to remain steady during measurement. Visual Examination : There shall be no evidence of mechanical damage. 9 Freque Vibration and Capacitance : Initial value to remain steady during measurement. Visual Examination : There shall be no evidence of mechanical damage.	yocol losc 28 42 85 104 17 21 28 37 82 protective resistance : 1000 Ω rge resistance : 1000 Ω rge resistance : 1000 Ω remement after test: After the capacitor being d under standard atmospheric conditions for purs, leakage current, capacitance and pation factor shall be measured. $\frac{1}{5}\frac{101-1}{10}\frac{1}{4}\frac{34}{34}$
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Vibratic angled Duratic perpendirectic directic	5101-1 4.17
angled Duratiti perpen directic	ency range: 10-55 Hz Swing width: 1.5 mm on direction: 3 directions with mutually right-
Duratic perpen directic	, 0
perpen directic	on : 2 hours in each of these mutually
direction	
	ons (total 6 hours)
Mount	ng : Solder terminal to the printed board
	ig . Golder terminal to the printed board
9 Shock There shall be no intermittent contact of 0.5 ms or greater, short, or open. Nor shall there be any spark discharge, JIS C 5	5101-1 4.19
insulation breakdown, or evidence of mechanical damage.	acceleration: 490 m/s ²
	on : 11 ms
	form : Half-sine
10 Solderability Shall be covered to over 95% of terminal surface by new soldering. JIS C 5	5101-1 4.15
Solder	temperature : 245 ±2°C
	g time : 5 seconds
	g depth : Terminal shall be dipped into
	ed solder
	5101-1, 4.14
	ow Preheating: 150 to 200°C, 60 to 120 sec
Dissipation Factor: Shall not exceed 1.3-times of the value in No.3.	Reflow: 217°C, 60 to 150 sec
Equivalent Series Resistance : Shall not exceed 2-times of the value in No.4.	Peak : 250°C max.
	er of cycles : 2
	5101-1 4.31
	erature : 23 ±5°C
	g time : 5 ±0.5 min.
	ioning : JIS C 0052 method 2
	t : 2-proparol (Isopropyl alcohol)
	5101-1 4.32 erature : 23 ±5°C
	g time : 5 ±0.5 min.
	g time : 5 ±0.5 min. ioning : JIS C 0052 method 2
	it : 2-proparol (Isopropyl alcohol) 5101-1, 4.16
	: -55 ±3°C, 30 ±3 min
	: 25 +10/-5°C, 3 min or less
	: 105 ±2°C, 30 ±3 min
	: 25 +10/-5°C, 3 min or less
	er of cycles : 100
	rement after test: After the capacitor being
	rement after test: After the capacitor being d under standard atmospheric conditions for
	ours, leakage current, capacitance and
	pation factor shall be measured.
	5101-1, 4.21
	erature : 65 ±2°C
	re : 90 to 95% RH
	on : 500 +24/0hrs
	rement after test: After the capacitor being
	d under standard atmospheric conditions for
24 hd	ours, leakage current, capacitance and
	pation factor shall be measured.
	5101-1, 4.23
	mperature : 85 ±2°C
	d voltage : Rated voltage
Equivalent Series Resistance : Shall not exceed 2-times of the value in No.4. Duratic	on: 1000 +48/0hrs
	supply impedance : 3Ω or less
Visual Examination : There shall be no evidence of mechanical damage.	rement after test: After the capacitor being
Visual Examination : There shall be no evidence of mechanical damage. Power Measu	d under standard atmospheric conditions for
Visual Examination : There shall be no evidence of mechanical damage. Power Measu store	ours, leakage current, capacitance and
Visual Examination : There shall be no evidence of mechanical damage. Power Measu store 24 hr	pation factor shall be measured.
Visual Examination : There shall be no evidence of mechanical damage. Power Measu store 24 h dissi	5101-1, 4.23
Visual Examination : There shall be no evidence of mechanical damage. Power Measu store 24 hr dissi; Power Measu store 21 hr dissi; Power Measu store 22 hr dissi; Power Measu store 22 hr dissi; Power Measu store 22 hr dissi;	
Visual Examination : There shall be no evidence of mechanical damage. Power Measus store 24 hr dissipation of the value in No.1. Endurance II Leakage Current : Shall not exceed 3-times of the value in No.1. Capacitance change : Within ±20% of the value before test. Test te	emperature : 105 ±2°C
Visual Examination : There shall be no evidence of mechanical damage. Power Measu store 24 hr dissil Power Leakage Current : Shall not exceed 3-times of the value in No.1. Capacitance change : Within ±20% of the value before test. Dissipation Factor : Shall not exceed 3-times of the value in No.3. Applied The Power Measu Store 24 hr dissil	emperature : 105 ±2°C d voltage : Derated voltage
Visual Examination : There shall be no evidence of mechanical damage. Power Measu store 24 hr dissipation in the store of the value in No.1. Production of the value in No.1. Capacitance change : Within ±20% of the value before test. Dissipation Factor : Shall not exceed 3-times of the value in No.3. Equivalent Series Resistance : Shall not exceed 2-times of the value in No.4. Duratic	emperature : 105 ±2°C d voltage : Derated voltage on : 1000 +48/0hrs
Visual Examination : There shall be no evidence of mechanical damage. Power Measu store 24 hr dissipation : There shall not exceed 3-times of the value in No.1. If Endurance II Leakage Current : Shall not exceed 3-times of the value in No.1. Capacitance change : Within ±20% of the value before test. Dissipation Factor : Shall not exceed 3-times of the value in No.3. Equivalent Series Resistance : Shall not exceed 2-times of the value in No.4. Visual Examination : There shall be no evidence of mechanical damage. Power	emperature : 105 ±2°C d voltage : Derated voltage on : 1000 +48/0hrs supply impedance : 3Ω or less
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Visual Examination : There shall be no evidence of mechanical damage. Power Measus store 24 hr dissipation in the state of the value in No.1. Endurance II Leakage Current : Shall not exceed 3-times of the value in No.1. Capacitance change : Within ±20% of the value before test. Dissipation Factor : Shall not exceed 3-times of the value in No.3. Equivalent Series Resistance : Shall not exceed 2-times of the value in No.4. Visual Examination : There shall be no evidence of mechanical damage. Power Measus store	emperature : 105 ±2°C d voltage : Derated voltage on : 1000 +48/0hrs supply impedance : 3Ω or less rement after test: After the capacitor being



✓! Application Notes for Tantalum Solid Electrolytic Capacitor with Conductive Polymer Type TCD

1. Operating voltage

Temperature derating is as follws.

Conditions of Use	-55°C to 85°C	85°C to 105°C	
Maximum derating required for the actual	000/11D	700/110	
voltage of products with UR ≤ 10V used in the filter circuit	90%UR	72%UR	
Maximum derating required for actual voltage	80%UR	C40/ LID	
of UR ≥ 10V products	80%UR	64%UR	

UR:Rated Voltage

2. Application that contain AC Voltage

Special attention to the following 3 items.

- (1) The sum of the DC bias voltage and the positive peak value of the AC voltage should not exceed the rated voltage.
- (2) Reverse voltage should not exceed the allowable values of the negative peak AC voltage.
- (3) Ripple voltage should not exceed the allowable values

3. Reverse voltage

Special attention to the polar character. Reverse Voltage should not be applied.

4. Permissible ripple current

The permissible ripple current and voltage at about 100 kHz or higher can be determined by the following formula from the permissible power loss for each case code (Pmax value) shown in Table 1 and the specified ESR value. However, when the expected operating temperature is higher than room temperature, determine the permissible values multiplying the Pmax value by the specified multiplier (Table 2). For the permissible values at different frequencies, consult our Sales Department.

$$P=I^{2}$$
 xESR or $P=$
$$\frac{E^{-2} \times ESR}{Z^{-2}}$$

$$Permissible ripple current \ lmax=\sqrt{\frac{P \ max}{ESR}} \quad (Arms)$$

Imax: Permissible ripple current at regulated frequency (Arms : RMS value) Emax: Permissible ripple voltage at regulated frequency (Vrms : RMS value)

Pmax: Permissible power loss (W) ESR: Specified ESR value at regulated frequency (Ω) Z : Impedance at regulated frequency (Ω)

Permissible ripple voltage Emax $\overline{\sqrt[]{P \max}}$ $\times Z = Imax \times Z (Vrms)$

Table 1 Permissible power loss for each case code

ı	ь	0.225	
	D	0.225	
	Case Code	Pmax (W)	

Note: Above values are measured at 0.8t glass epoxy board mounting in free air and may be changed depending on the kind of board, packing density, and air convection condition. Please consult us if calculated power loss value is equal to or greater than above list of Pmax value.

Table 2 Pmax multiplier at each operating temperature

Temperature	25°C	85°C	125℃
Derating factor	1.0	0.9	0.4

5. Non Polar Connection

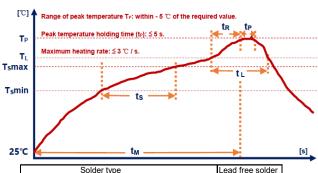
The capacitor cannot be used as a non-polar unit.

6. Soldering

6.1 Soldering

(1) Reflow Soldering

The peak setting temperature TP of SMT should be ≤ 250 °C, and the holding time within the range of 0 °C ~ - 5 °C of the peak temperature TP should be ≤ 5s.



	Solder type	Lead free solder
Min	Minimum preheating temperature	150°C
TS Max	Maximum preheating temperature	200°C
tS	Preheating time	60~120s
TL ~ TP	Heating rate	≤3°C/s
TL	Melting point of solder paste	217℃
tL	Melting time of solder paste	60~150s
TP	Peak temperature	250°C
tP	Holding time of peak temperature	≤10s ≤3s or 5s
TP ~ TL	Cooling rate	s ≤6°C/s
tM	Time from 25 ° C to peak temperature	≤8 min

(2) Manual welding

If manual welding is required under special circumstances, the power of electric iron should bee ≦60W, the temperature should be ≦350 °C, and the welding time should be ≦5s. It is forbidden for the iron head to directly contact the product body, and the solder should be melted to make it contact with the capacitor pin for welding.

(3) Please consult us for other methods.

Cleaning by organic solvent may damage capacitor's appearance and performance. However, our capacitors are not effected even when soaked at 20-30°C 2-propanol for 5 minutes. When introducing new cleaning methods or changing the cleaning term, please consult us.

8. Storage

Capacitors should be tightly sealed in moisture prevention bag and stored with supplied reel. After unpacking, capacitors should be used within the floor life listed in Table 3. Moisture Sensitivity Level : Table 3 shows the moisture sensitivity level and the floor life of the dampproof wrapping products.

Table 3 MSL&Floor Life

JEDEC MSL	Floor Life				
٥	168hrs.(7days)				
3	Less than 30℃/60%RH				
(Reference IPC/JEDEC J-STD-020C July 2004					

9. Inapplicable circuits

The capacitors may cause nonconformity if they are used on the following circuits.

- (1) High-impedance voltage holding circuits
- (2) Coupling circuits
- (3) Time constant circuits
- (4) Circuits significantly affected by leakage current

If a short circuit occurs, the capacitors may generate heat or smoke depending on the short-circuit current. When designing a circuit, take the instructions stated herein into consideration, and take as much redundant measures as possible.

10. Additional Notes

Wear-out failure (Lifetime)

When the operating time exceeded the specified guarantee time of Endurance and Damp heat, the electric characteristics changes significantly and the open circuit might be caused by the degradation of electrolyte.

Please note that the electric characteristics of capacitance and ESR might change within the specified range in specifications when it used under the condition of electric and mechanical performance.

These application notes are prepared based on the technical report RCR-2368B "Guideline of notabilia for fixed tantalum electrolytic capacitors with solid electrolyte for use in electronic equipment" issued by Japan Electronics and Information Technology Industries Association. For the details of the instructions (explanation, reasons and concrete examples), please refer to this guideline, or consult our Sales Department.



MATSUO ELECTRIC CO., LTD.

Please feel free to ask our Sales Department for more information on Tantalum Solid Electrolytic Capacitor with Conductive Polymer.

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Specifications on this catalog are subject to change without prior notice. Please inquire of our Sales Department to confirm specifications prior to use.

市場	適用 用途 分類	用	推奨品種	
印场		概要	代表的なアプリケーション例	チップタンタルコンデンサ
高信頼度 機器	1	 高度な安全性や信頼性が要求される機器 製品の保守交換が不可能な機器、製品の故障が人命に 直接かかわる、または、致命的なシステムダウンを引 き起こす可能性がある機器 	・宇宙開発機器関連(衛星、ロケット、人工衛星)・航空・防衛システム・原子力・火力・水力発電システム	
	2	・信頼性が重視される機器 ・製品の保守交換が極めて困難な機器や、製品の故障が 人命に影響する、あるいは故障の範囲が広範囲である 機器	・自動車および鉄道・船舶等の輸送機器の車両制御 (エンジン制御,駆動制御,プレーキ制御) ・新幹線・主要幹線の運行制御システム	
車載• 産業機器	3	 製品の保守交換が可能な機器や、製品の故障が人命に 影響しないが故障によるシステムダウンの損失が大き く保全管理が要求される機器 	・エアコン,カーナビ等の車室内搭載部品、 車載用通信機器 ・家庭用/ビル用等のセキュリティ管理システム ・工業用ロボットや工作機械等の制御機器	
汎用機器	・展先端技術を積極的に適用する小型・薄型品 ・製品の保守交換が可能な機器や、製品の故障による ・製品の保守交換が可能な機器向けの市場で広く 使用されることを想定した製品		 スマートフォン、携帯電話、モバイルPC(タブレット)、電子辞書 デスクトップPC、ノートPC、ホームネットワーク アミューズメント機器(バチンコ、ゲーム機) 	TCD型

Market	Application classification	U	Recommendation Type	
iviarket	by use	Outline Typical example of application		Chip Tantalum Capacitors
High reliability apparatus	1	- Apparatus in which advanced safety and reliability are demanded Whether failure of the apparatus which cannot maintenance exchange products, and a product is direct for a human life, apparatus which changes or may cause a fatal system failure.	- Space development apparatus relation (Satellite, Rocket, Artificial Satellite) - Aviation and a defensive system - Atomic power, fire power, and a water-power generation system	
In-vehicle	2	 Apparatus in which reliability is important. The apparatus in which maintenance exchange of a product is very difficult, and failure of a product influence a human life, or the range of failure is wide range. 	- Vehicles control of transport machines, such as a car, and a railroad, a vessel (Engine control, drive control, brake control) - The operation control system of the Shinkansen and a main artery	
Industrial apparatus	3	-Apparatus which can maintenance exchange products, and apparatus in which the loss of the system failure is large although failure of a product does not influence a human life, and maintenance engineering is demanded	- Vehicle indoor loading parts, such as an air-conditioner and car navigation, and in-vehicle communication facility - Security management system for home/buildings etc Control apparatus, such as industrial use robots and a machine tool etc.	
Apparatus in general	4	- The small size and the thin article which applies leading-edge technology positively - The product supposing being used widely in the market for the apparatus which can maintenance exchange products, and apparatus with a partial system failure by failure of product.	-Smart phone, Mobile phone, Mobile PC (tablet), Electronic dictionary - Desktop PC, Notebook PC, Home network - Amusement apparatus (Pachinko,Game machine)	Type TCD

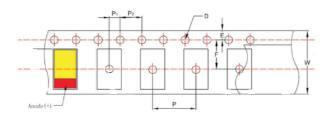
テーピング数量・リール寸法 Taping Quantity And Carrier Tape Dimensions

チップタンタルコンデンサ Chip Tantalum Capacitors

定格:TCD型 Type:TCD

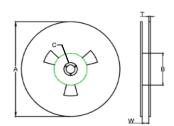
ケース記号	ケースサイズ	W	W F	E	Р	P ₁	P_2	ϕD_0	包装数/リール(個) Quantity/Reel (pcs)
Case Code	Case size	(mm)	(mm)	(mm)	(mm)	(mm)	(mm)	(mm)	φ 180
D	7.3×4.3×2.8	12±0.30	5.5±0.10	1.75±0.10	4±0.10	8±0.05	2±0.10	1.55±0.20	500

テーピング寸法/Tape dimensions



単位[mm] unit[mm]

リール寸法/Reel dimensions



リール Reel	テープ幅 Tape width	Α	В	С	W	Т
φ180	12	178±2.00	50 min	13.0±0.50	12.4+1.5/-0	1.50±0.50